

# FDS6294

## 30V N-Channel Fast Switching PowerTrench® MOSFET

### General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{DS(ON)}$  and fast switching speed.

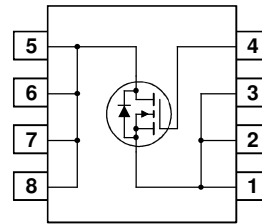
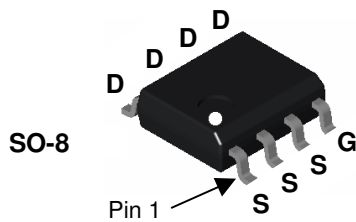
### Applications

- DC/DC converter
- Power management
- Load switch



### Features

- 13 A, 30 V.  $R_{DS(ON)} = 11.3\text{ m}\Omega @ V_{GS} = 10\text{ V}$   
 $R_{DS(ON)} = 14.4\text{ m}\Omega @ V_{GS} = 4.5\text{ V}$
- Low gate charge (10 nC typical)
- High performance trench technology for extremely low  $R_{DS(ON)}$
- High power and current handling capability.
- RoHS Compliant



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current – Continuous (Note 1a)	13	A
	– Pulsed	50	
$P_D$	Power Dissipation for Single Operation (Note 1a)	3.0	W
	(Note 1b)	1.2	
$E_{AS}$	Single Pulse Avalanche Energy (Note 3)	181	mJ
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	$-55$ to $+175$	$^\circ\text{C}$

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	50	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1b)	125	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	25	

### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS6294	FDS6294	13"	12mm	2500 units

## Electrical Characteristics

T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		27		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μA
I <sub>GSS</sub>	Gate–Body Leakage	V <sub>GS</sub> = ± 20 V, V <sub>DS</sub> = 0 V			±100	nA

### On Characteristics (Note 2)

V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		–5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13 A V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 12 A V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13 A, T <sub>J</sub> = 125°C		9.4 11.5 13.5	11.3 14.4 16.5	mΩ
I <sub>D(on)</sub>	On–State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	50			A
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 13 A		48		S

### Dynamic Characteristics

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		1205		pF
C <sub>oss</sub>	Output Capacitance			323		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			102		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		0.9		Ω

### Switching Characteristics (Note 2)

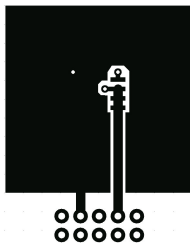
t <sub>d(on)</sub>	Turn–On Delay Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 1 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		9	18	ns
t <sub>r</sub>	Turn–On Rise Time			4	8	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			24	48	ns
t <sub>f</sub>	Turn–Off Fall Time			6	12	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 13 A, V <sub>GS</sub> = 5 V		10	14	nC
Q <sub>gs</sub>	Gate–Source Charge			3.5		nC
Q <sub>gd</sub>	Gate–Drain Charge			3		nC

### Drain–Source Diode Characteristics and Maximum Ratings

I <sub>S</sub>	Maximum Continuous Drain–Source Diode Forward Current			2.1		A
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.1 A (Note 2)		0.74	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 13 A, dI <sub>F</sub> /dt = 100 A/μs		25		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge			14		nC

#### Notes:

- R<sub>θJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>θJC</sub> is guaranteed by design while R<sub>θCA</sub> is determined by the user's board design.



a) 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b) 125 °C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

- Test: Pulse Width < 300 μs, Duty Cycle < 2.0%
- Starting T<sub>J</sub> = 25 °C, L = 3 mH, I<sub>AS</sub> = 11 A, V<sub>DD</sub> = 30V, V<sub>GS</sub> = 10V

### Typical Characteristics

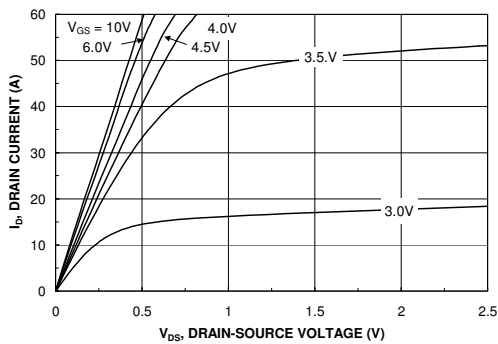


Figure 1. On-Region Characteristics.

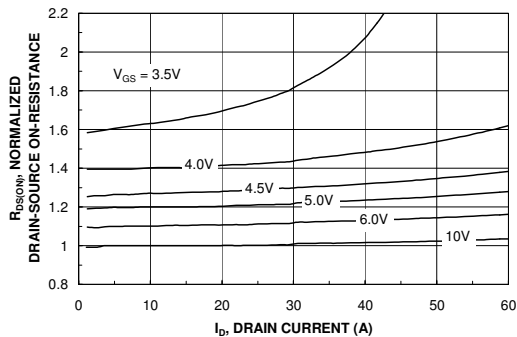


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

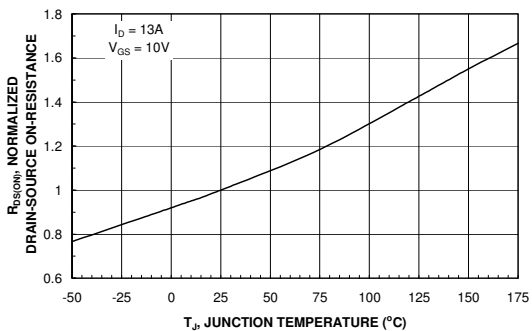


Figure 3. On-Resistance Variation with Temperature.

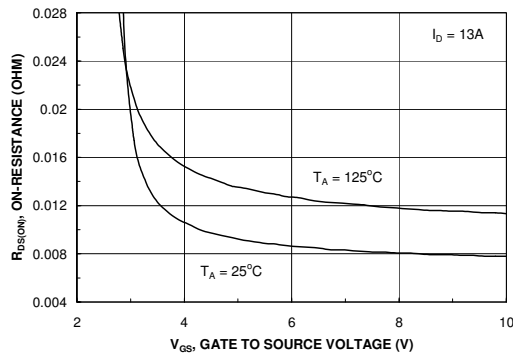


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

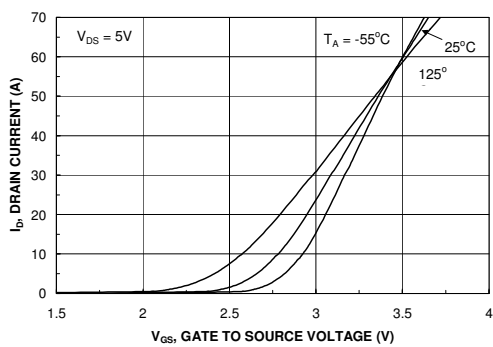


Figure 5. Transfer Characteristics.

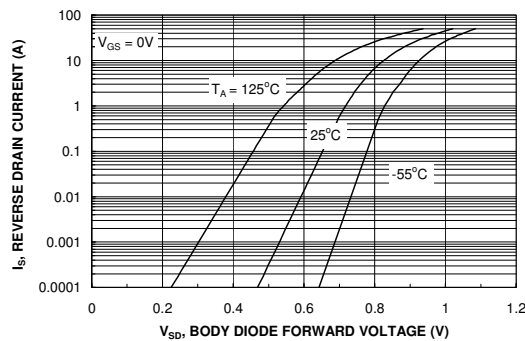


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics

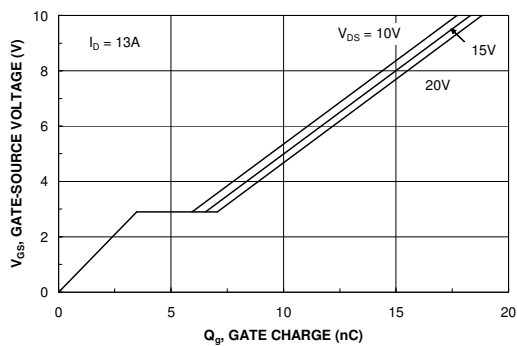


Figure 7. Gate Charge Characteristics.

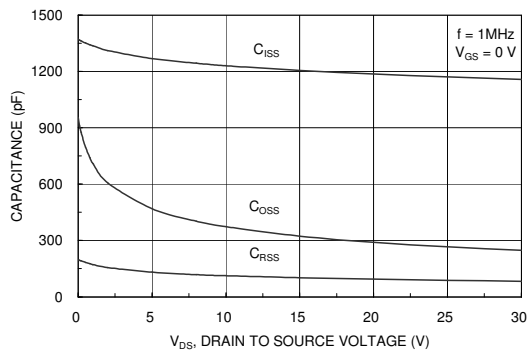


Figure 8. Capacitance Characteristics.

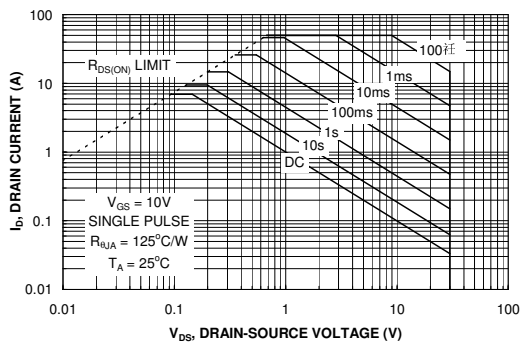


Figure 9. Maximum Safe Operating Area.

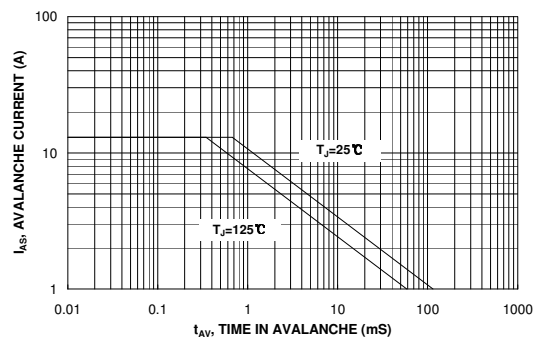
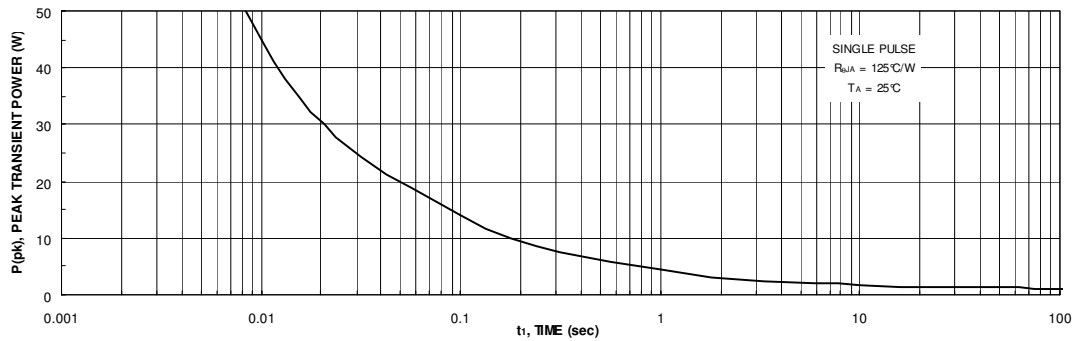
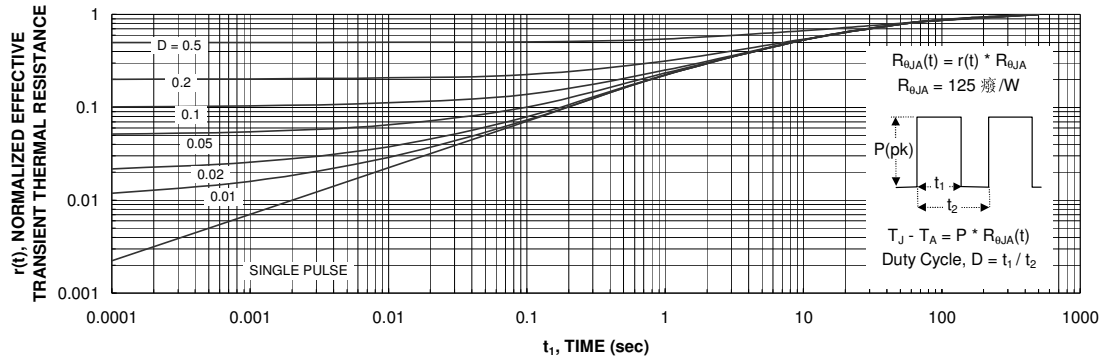


Figure 10. Unclamped Inductive Switching Capability Figure



11. Single Pulse Maximum Power Dissipation.

## Typical Characteristics



**Figure 12. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1c.  
 Transient thermal response will change depending on the circuit board design.

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